WHAT IS CLAIMED IS:

- 1. An apparatus for controlling motion of an object, comprising:
- a first actuator for moving an object;

an elastic-motion measuring unit for measuring elastic motion of the object; and

a control unit for controlling said first actuator based on an elastic motion measured by said elastic motion measuring unit.

- 2. An apparatus according to Claim 1, further comprising:
- a rigid-motion measuring unit for measuring rigid motion of the object,

wherein said control unit controls said first actuator based on a rigid motion measured by said rigid motion measuring unit.

- 3. An apparatus according to Claim 1, further comprising:
 a second actuator for suppressing elastic motion of the object,
 wherein said control unit controls said second actuator based on an
 elastic motion measured by said elastic motion measuring unit.
- 4. An apparatus according to Claim 1, wherein said control unit comprises a prediction unit for predicting an elastic motion of the object caused by said first actuator, and controls said first actuator based on prediction made by said prediction unit.
 - 5. An apparatus according to Claim 3, wherein said control unit

comprises a prediction unit for predicting an elastic motion of the object caused by said first actuator, and controls said second actuator based on a prediction made by said prediction unit.

- 6. An apparatus according to Claim 1, wherein said elastic motion measuring unit comprises a piezoelectric element.
- 7. An apparatus according to Claim 3, wherein said second actuator comprises a piezoelectric element.
- 8. An exposure apparatus for exposing a substrate to a pattern of an original, said exposure apparatus comprising the apparatus defined in Claim 1.
- 9. An exposure apparatus according to Claim 8, wherein the apparatus defined in Claim 1 includes a stage for holding one of the substrate and the original.
- 10. A device manufacturing method, comprising a step of exposing a substrate to a pattern of an original using the apparatus defined in Claim 1.
 - 11. An apparatus for controlling motion of an object, comprising:
 - a first actuator for moving an object;
 - a second actuator for suppressing elastic motion of the object; and
- a control unit for controlling said second actuator based on a prediction of the elastic motion of the object caused by said first actuator.

12. An apparatus according to Claim 11, further comprising: an elastic-motion measuring unit for measuring elastic motion of the object,

wherein said control unit controls said second actuator based on an elastic motion measured by said elastic motion measuring unit.

- 13. An apparatus according to Claim 11, further comprising:
- a rigid motion measuring unit for measuring rigid motion of the object,

wherein said control unit controls said first actuator based on a rigid motion measured by said rigid-motion measuring unit.

- 14. An exposure apparatus for exposing a substrate to a pattern of an original, said exposure apparatus comprising the apparatus defined in Claim 11.
- 15. An exposure apparatus according to Claim 14, wherein the apparatus defined in Claim 11 includes a stage for holding one of the substrate and the original.
- 16. A device manufacturing method, comprising a step of exposing a substrate to a pattern of an original using the exposure apparatus defined in Claim 14.